

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re Application of Applicants:

Beaman et al.

Serial No.: 09/921,867

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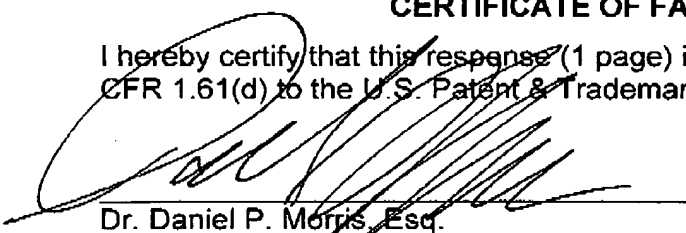
For: HIGH DENSITY INTEGRATED CIRCUIT APPARATUS, TEST PROBE AND  
METHODS OF USE THEREOF

Date: February 2, 2005

Group Art Unit: 3729

Examiner: A. D. Tugbang

Docket No.: YOR919930028US6

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FEB 02 2005**Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450**CERTIFICATE OF FACSIMILE TRANSMISSION**I hereby certify that this response (1 page) is being facsimile transmitted under Rule 37  
CFR 1.61(d) to the U.S. Patent & Trademark Office to (703) 872-9306 on February 2, 2005.  
Dr. Daniel P. Morris, Esq.  
Reg. No. 32,053**RESPONSE TO RESTRICTION REQUIREMENT DATED JANUARY 27, 2005****REMARKS**Applicants elect, without traverse, Claim Group I-A (claims 29-62) and subgroup I-A1  
(claims 29-52).Please charge any fee necessary to enter this paper and any previous paper to  
deposit account 09-0468.

Respectfully submitted,

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